

# MPZ5-16 - MPZ5-32 - MPZ5-180 Series

Silicon power transient suppressor designed for applications requiring protection of voltage sensitive electronic devices in danger of destruction by high energy voltage transients. Individual cells are matched to insure current-sharing under high current pulse conditions.



## MAXIMUM RATINGS

Transient Power Dissipation: 40 kW  
Pulse Width: 0.1 ms, (See Figure 1)

DC Power Dissipation: 350 Watts @  $T_c = 25^\circ\text{C}$   
(Derate 2.33 W/ $^\circ\text{C}$  above  $25^\circ\text{C}$ )

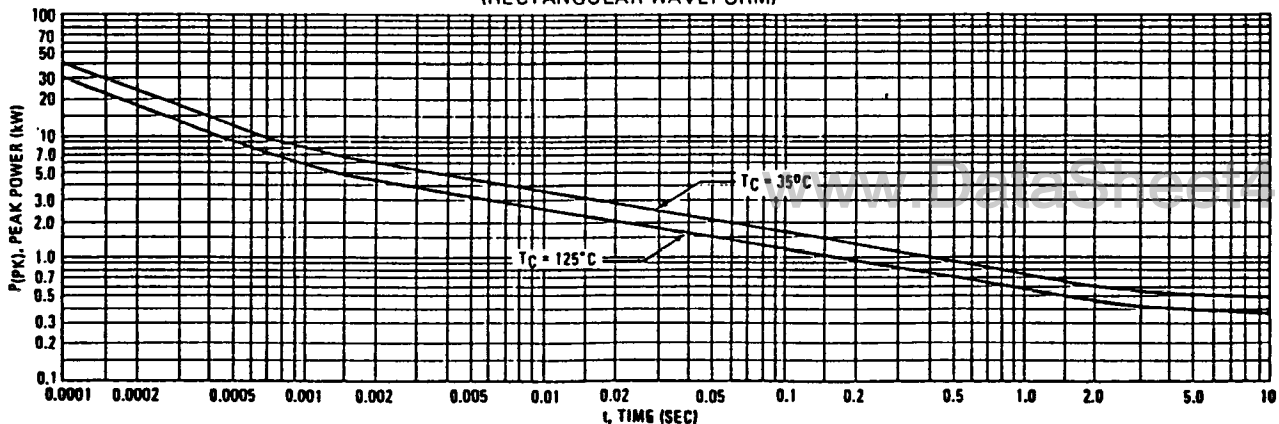
Operating Junction & Storage Temperature  
Range:  $-65^\circ\text{C}$  to  $+175^\circ\text{C}$

Polarity:  
Anode-to-Case is Standard  
Cathode-to-Case Available Upon Request

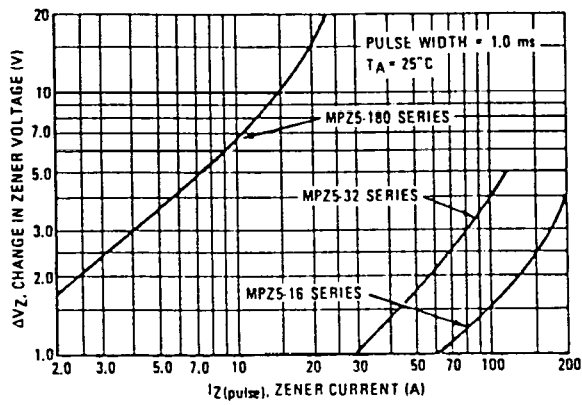
ELECTRICAL CHARACTERISTICS ( $T_A = 25^\circ\text{C}$ ) ( $V_F = 1.5\text{ V max @ } 10\text{ A}$  for all types)

Type	Nominal Operating Voltage (Note 1)		Maximum Device Clamping Factor $CF = \frac{V_Z @ I_Z (\text{pulse})}{V_Z @ I_{ZT}}$	Minimum Zener Voltage		Maximum Zener Voltage Pulse Width = 1.0 ms		Maximum Reverse Current $I_R(\text{max})$ @ $V_R = V_{OP}(\text{PK})$ uAdc	Typical Capacitance C (typ) @ $V_R = V_{OP}(\text{PK})$ uF
	VOP (PK) Vdc	VOP(RMS) Vrms		VZ @ I <sub>ZT</sub> (Note 2)	VZ(min) @ I <sub>ZT</sub> Vdc Adc	VZ(max) @ I <sub>Z</sub> (pulse) Vdc Adc			
MPZ5-16A	14	10	1.25	16	0.4	24	200	50	0.025
-16B	14	10	1.25	16	0.4	20	200	50	0.025
-32A	28	20	1.25	32	0.2	50	100	50	0.011
-32B	28	20	1.25	32	0.2	45	100	50	0.011
-32C	28	20	1.25	32	0.2	40	100	50	0.011
-180A	165	117	1.14	180	0.03	250	20	50	0.0012
-180B	165	117	1.14	180	0.03	225	20	50	0.0012
-180C	165	117	1.14	180	0.03	205	20	50	0.0012

FIGURE 1 – MAXIMUM NON-REPETITIVE SURGE POWER (RECTANGULAR WAVEFORM)



**FIGURE 2 - TYPICAL DYNAMIC ZENER VOLTAGE CHARACTERISTICS (Note 2)**



NOTE 1: Nominal operating voltage is defined as normal input voltage to device for non-operating condition. If non-sinusoidal wave or dc input is present, peak voltage input values VOP(PK) should be used to select device type.

NOTE 2: The maximum device clamping factor CF is a ratio of  $V_z$  measured at  $I_z$  (pulse) given in the Electrical Characteristics Table divided by  $V_z$  measured at  $I_{zT}$  under steady state conditions. This value guarantees the sharpness of the voltage breakdown of individual devices. Figure 2 demonstrates the typical sharpness of the breakdown, and indicates the voltage regulation over a wide range of currents.

$$\Delta V_z = V_z @ I_z(\text{pulse}) - V_z @ I_{zT}$$